

<b>Notice of References Cited</b>	Application/Control No. 10/647,775		Applicant(s)/Patent Under Reexamination YAN ET AL.	
	Examiner Khanh V. Nguyen		Art Unit 2817	Page 1 of 1

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*	C	US-6,639,460	10-2003	Botker, Thomas L.	330/9
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	L	US-			
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**NON-PATENT DOCUMENTS**

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